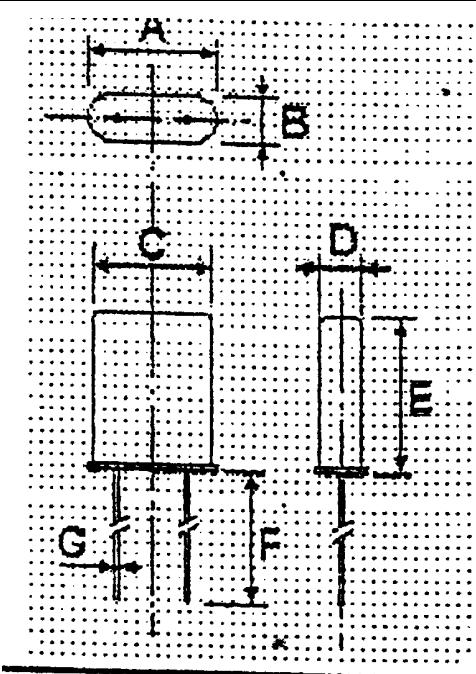


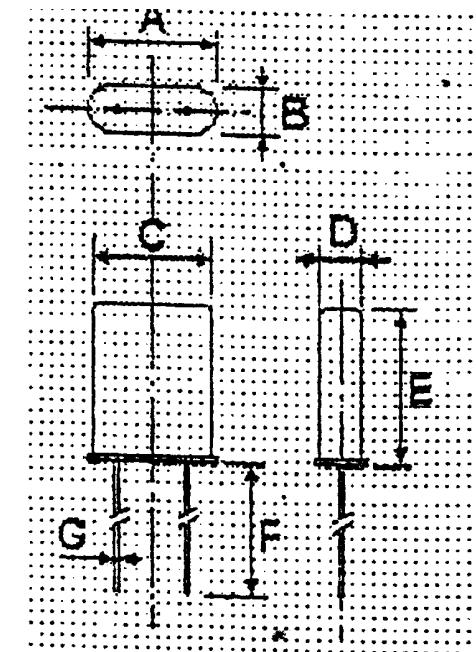
Specification of Quartz Crystal

PARAMETER	SPEDIFICATION
Nominal Freq.	21.145MHz
Holder	UM-1 (Size See Picture)
Freq. Tolerance	+/- 20ppm at 25 +/- 2 degree C
Temperature Stability	Fs +/- 15ppm, referenced to 25C-20 to+60C
Operating Range	-20C to +60C
Equivalent Res.Rs	25 ohms MAX
Mode of Oscillation	fund
Shunt Capacitance Co	5 PF MAX
Load Capacitance CL	20 PF
Storage Range	-40 to +90C
Drive Level DL	10 uW +/-0.1uW
Aging	+/- 3ppm per year
Insulation	500 Mohm MAX (at DC100V +/-15V)
Leakage Test	No continuous air bubbles from can in the warm 80C in 5 minutes
Shock Test	Freq. shift +/-5PPM & Res.+/- 15% after test (dropping from 75cm height 3 times on wood)
Measurement	KH1200 PI-Net. Crystal Measurement System
Marking	TEK Nominal freq.
Dimension:	UNIT: mm
Code	Size
A	7.75+/-0.10
B	3.05+/-0.10
C	6.90+/-0.05
D	2.20+/-0.05
E	7.80+/-0.10
F	13.32+/-0.5
G	0.35+/-0.05



Specification of Quartz Crystal

PARAMETER	SPEDIFICATION
Nominal Freq.	12.800MHz
Holder	UM-1 (Size See Picture)
Freq. Tolerance	+/- 5ppm at 25 +/- 2 degree C
Temperature Stability	Fs+/-5ppm, referenced to 25C; -20 to+60C
Operating Range	-20C to +60C
Equivalent Res.Rs	25 ohms MAX
Mode of Oscillation	fund
Shunt Capacitance Co	5 PF MAX
Load Capacitance CL	12 PF
Storage Range	-40 to +90C
Drive Level DL	10 uW +/-0.1uW
Aging	+/- 3ppm per year
Insulation	500 Mohm MAX (at DC100V +/-15V)
Leakage Test	No continuous air bubbles from can in the warm 80C in 5 minutes
Shock Test	Freq. shift +/-5PPM & Res.+/- 15% after test (dropping from 75cm height 3 times on wood)
Measurement	KH1200 PI-Net. Crystal Measurement System
Mrking	TEK Nominal freq.
Dimension:	UNIT: mm
Code	Size
A	7.75+/-0.10
B	3.05+/-0.10
C	6.90+/-0.05
D	2.20+/-0.05
E	7.80+/-0.10
F	13.32+/-0.5
G	0.35+/-0.05



SPECIFICATION OF QUARTZ CRYSTAL

1	Frequency	69.3125MHZ
2	Holder type	UM-1
3	Frequency Tolerance at 25C	+/-5PPM
4	Temperature Drift	+/-5PPM
5	Operating Temperature Range	-20°C ~ +60°C
6	Locd Capacitance	15pf
7	Mode of Oscillation	3rd overtone
8	Equivalent Series Resistance	30 ohm max 10uW
9	Shunt Capacitance	7pf max
10	Drive leve	10uW
11	Aging/year	+/-3ppm
12	Motional Capacitance	<1.5nF

SPECIFICATION OF QUARTZ CRYSTAL

1	Nominal Frequency	17.9MHZ
2	Case type	UM-1
3	Mode of oscillation	Fundamental Frequency
4	Number of poles	4 poles
5	Passband width	$\geq \pm 7.5\text{KHZ}$ (at 18dB)
6	Stopband width	$\leq \pm 25\text{KHZ}$ (at 18dB)
7	Attenuation guaranteed	65dB min($f_0 +350 \sim +1000\text{KHZ}$) 80dB min($f_0 -200 \sim +1000\text{KHZ}$)
8	Ripple	1.0dB max
9	Insertion loss	2.5dB max
10	Terminating Impedance	$1600 \Omega // 2\text{pf}$
11	Operating temperature range	$-30^\circ\text{C} \sim +70^\circ\text{C}$
Remarks:		

SPECIFICATION OF MONOLITHIC FILTER

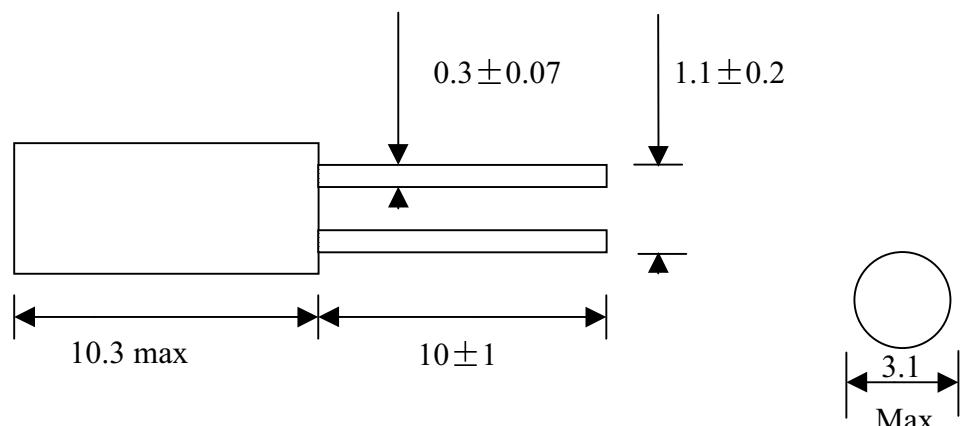
1	Nominal Frequency	21.600MHz
2	Case type	UM-1
3	Mode of oscillation	Fundamental Freq
4	Number of poles	4 poles
5	Passband width	$\geq \pm 7.5\text{KHz}$ (at 3dB)
6	Stopband width	$\leq \pm 25\text{KHz}$ (at 40dB)
7	Attenuation guaranteed	65dB min ($f_o + 350 \sim +1\text{MHz}$) 50dB min ($f_o - 200 \sim -1\text{MHz}$)
8	Ripple	1.0dB max
9	Insertion loss	2.5dB max
10	Terminating Impedance	$1600 \Omega // 2\text{pt} \pm 0.5\text{pf}$
11	Operating temperature range	-30°C ~ +70°C
Remarks: Coupling Capacitor Cj=8pt		

Specification of Quartz Crystal

PARAMETER	SPEDIFICATION
Nominal Freq.	18.355MHz
Holder	UM-1
Freq. Tolerance	+/- 20ppm at 25 +/- 2 degree C
Temperature Stability	Fs +/- 20ppm, referenced to 25C
Operating Range	-20°C to +60°C
Equivalent Res.Rs	25 ohms MAX
Mode of Oscillation	fund
Shunt Capacitance Co	5 PF MAX
Load Capacitance CL	20PF
Storage Range	-40°C to +90°C
Drive Level DL	10 uW +/-0.1uW
Aging	+/- 3ppm per year
Insulation	500 Mohm MAX (at DC100V +/-15V)
Leakage Test	No continuous air bubbles from can in the warm 80C in 5 minutes
Shock Test	Freq. shift +/-5PPM & Res.+/- 15% after test (dropping from 75cm height 3 times on wood)
Measurement	KH1200 PI-Net. Crystal Measurement System
Marking	TEK Nominal freq.

Specification of Quartz Crystal

PARAMETER	SPEDIFICATION
Nominal Freq.	8.388608 MHz
Frequency Tolernce	+/-30 PPM at 25Deg C
Load Capacitance	16pf
Drive Level	100 Uw Max
Series Resistance	150 ohm Max
Qfactor	40000 Min
Turnoyer Iemperaturs	25Deg C +/-5Deg C
Parabolic Curyature Constant	± 30 PPM Max
Insulation Resist Rance	500 Mohms min at 100v DC
Operatng Temp Rance	-20Deg C to +60Deg C
Storage Temp Rance	-20Deg C to 170Deg C
Shunt Capacitance	5PF +/- 0.3PF
Capacitance Ratto	700 MAX



SPECIFICATION OF CERAMIC FILTER

LT455FW

1. THIS SPECIFICATION SHALL COVER THE CHARACTERISTICS OF CERAMIC FILTER WITH 455KHz, INTENDED FOR USE IN TRANSCEIVERS, ETC.

2. PART NUMBER : LT455FW

3. ELECTRONICAL SPECIFICATIONS

- A. CENTRE FREQUENCY (f_c) : 455KHz \pm 1.5KHz. MAX.
- B. BAND WIDTH AT 6 dB : \pm 6.0 KHz MIN.(TO 455KHz)
- C. BAND WIDTH AT 50 dB : \pm 12.5 KHz MAX.(TO 455KHz)
- D. STOP BAND ATTENUATION : 40 dB MIN.(AT f_c \pm 100KHz)
- E. RIPPLE : 2.0dB MAX.(AT f_c \pm 1.0KHz)
- F. INSERTION LOSS : 6.0 dB MAX (AT THE SMALLEST LOSS)

G. TEMPRATURE COEFFICIENT
OF CENTER FRENQUENCY : \pm 50PPM/°C Max.(-20 TO +80°C)

H. INPUT/OUTPUT IMPEDANCE : 2K Ω

NOTE: A) CENTER FREQUENCY SHALL BE DEFINED AS THE CENTRAL
VALUE OF THE BAND WITH AT 6 dB

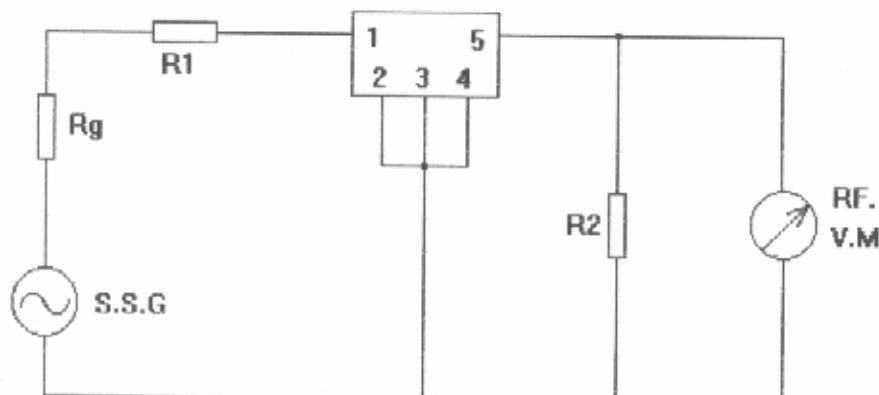
B) TEMPRATURE COEFFICIENT OF CENTER FREQUENCY
SHALL BE DEFINED AS THE AVERAGE OF THE CENTRAL
FREQUECY.

4. MEASUREMENT

A. ENVIRONMENTAL CONDITION

MEASUREMENT SHALL BE CARRIED OUT AT THE REFERENCE
TEMPERATURE OF 25°C \pm 2°C. IT SHALL BE POSSIBLY DONE
AT 5°C TO 35°C UNLESS IT IS QUESTIONABLE.

B. MEASURING CIRCUIT



R_g+R₁=R₂=Input/Output Impedance

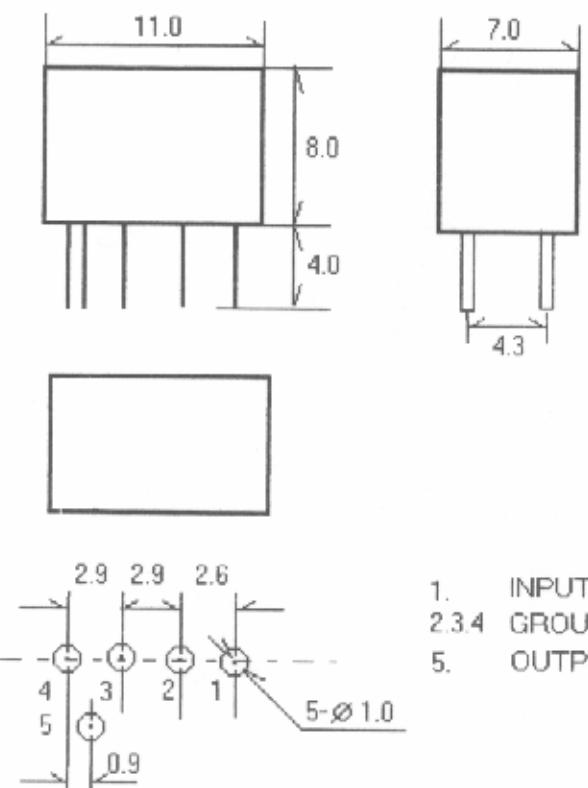
#S.S.G. (STANDARD SIGNAL GENERATION)

R.F.V.M. (RADIO FREQUENCY VOLTAGE METER)

$R_g + R_1 = R_2 = 1.5K \Omega$

$C \leq 50 \text{ PF}$

5. DIMENSIONS(mm)



6. ENVIRONMENTAL CHARACTERISTICS

6-1 HIGH TEMPERATURE EXPOSURE

SUBJECT THE FILTER TO $+80^\circ\text{C}$ FOR 96 HOURS. THEN RELEASE THE FILTER INTO THE SPECIFICATIONS IN TABLE 1.

6-2 MOISURE

KEEP THE FILTER AT 40°C AND 95% RH FOR 96 HOURS. THEN RELEASE THE FILTER INTO THE ROOM CONDITIONS FOR 1 TO 2 HOURS PRIOR TO THE MEASUREMENT. IT SHALL FULFILL THE SPECIFICATIONS IN TABLE 1.

6-3 LOW TEMPERATURE EXPOSURE

SUBJECT THE FILTER TO -20°C FOR 96 HOURS. THEN RELEASE THE FILTER INTO THE ROOM CONDITIONS FOR 1 TO 2 HOURS PRIOR TO THE MEASUREMENT. IT SHALL FULFILL THE SPECIFICATIONS IN TABLE 1.

6-4 TEMPERATURE CYCLING

SUBJECT THE FILTER TO A LOW TEMPERATURE OF -55°C FOR 30 MINUTES. FOLLOWING BY A HIGH TEMPERATURE OF $+85^\circ\text{C}$ FOR 30

MINUTES. THEN RELEASE THE FILTER INTO THE ROOM CONDITIONS FOR 1 TO 2 HOURS PRIOR TO THE MEASUREMENT. IT SHALL MEET THE SPECIFICATIONS IN TABLE 1.

6-5 RESISTANCE TO SOLDER HEAT

DIP THE FILTER TERMINALS NO CLOSER THAN 1.5mm INTO THE SOLDER BATH AT $270^{\circ}\text{C} \pm 10^{\circ}\text{C}$ FOR 10 ± 1 SEC. THEN RELEASE THE FILTER INTO THE ROOM CONDITIONS FOR 1 TO 2 HOURS. THE FILTER SHALL MEET THE SPECIFICATIONS IN TABLE 1.

6-6 MECHANICAL SHOCK

DROP THE FILTER RANDOMLY ONTO THE CONCRETE FLOOR FROM THE HEIGHT OF 30cm 3 TIMES. THE FILTER SHALL FULFILL THE SPECIFICATIONS IN TABLE 1.

6-7 VIBRATION

SUBJECT THE FILTER TO THE VIBRATION FOR 1 HOUR EACH IN X, Y AND Z AXES WITH THE AMPLITUDE OF 1.5 mm AT 10 TO 55 Hz. THE FILTER SHALL FULFILL THE SPECIFICATIONS IN TABLE 1.

6-8 LEAD FATIGUE

6-8-1 PULLING TEST

WEIGHT ALONG WITH THE DIRECTION OF LEAD WITHOUT AN SHOCK 3 KG. THE FILTER SHALL SATISFY ALL THE INITIALLY CHARACTERISTICS.

6-8-2 BENDING TEST

LEAD SHALL BE SUBJECT TO WITHSTAND AGAINST 90°C BENDING IN THE DIRECTION OF THICKNESS. THIS OPERATION SHALL BE DONE TOWARD BOTH DIRECTION. THE FILTER SHALL SHOW NO EVIDENCE OF DAMAGE AND SHALL SATISFY ALL THE INITIAL ELECTRICAL CHARACTERISTICS.

TABLE 1

ITEM	SPECIFICATION
CENTRE FREQUENCY(f.)	455 ± 1.5 KHz Max
BAND WIDTH(6 dB)	± 6.0 KHz Min
SELECTIVITY(50dB)	± 12.5 KHz Max
STOP BAND ATTENUATION	40 dB Min
RIPPLE	2.0 dB Max
INSERTION LOSS	6.0 dB Max